## Application/Control No. Applicant(s)/Patent Under Reexamination 10/797,579 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Yewebdar T. Tadesse 1734 **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 03-1994 Kelly et al. 118/52 US-5,294,257 Α \* US-6,012,858 01-2000 Konishi et al. 396/611 В \* US-5,857,127 01-1999 Chu, Ron-Fu 396/611 С US-D US-E US-F US-G US-Н

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N		•			
	0					
	Р					
	α					
	R		-			
	S					
	_					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>v</b>	
	W	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

US-

US-US-

US-US-

ı

K

М